ESCC

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL

Component Title:

Capacitors, Fixed, Chip, Ceramic Dielectric, type I, based on types 0805, 1206, 1210, 1812, 2220

Appl. No.

Page 1

	Executive Member:	CNES		Date: 17/12/2019	109P rev1	
ng series and families	s) submitted for Extension	of Qualification	Approval:		1	
VARIANTS	RANGE OF COI	MPONENTS	BASED ON	TEST VEHICLE / S	COMPONENT SIMILAR	
03, 06	See box 14		0805 1210	3009003061301JC 3009004061501FE 3009004061002JC AN13CE0392KT5		
03, 06	İ		1812	3009005061502JE	Click here to enter text.	
03, 06	ĺ		2220	3009006063302FE	Click here to enter text.	
03, 06		1206		3009022063921FE AN20CE0332KT2 AD20CE0272KT3	Click here to enter text.	
anufacturer	2 Location of Ma	anufacturing Plant	(s) 3		4	
rporation			е	Date of original qualification a Date: 01/02/1983 Certificate Ref No. 109	oproval:	
used for fication testing:	used:			reference and date:		
4 5	Deviation from curre				8	
ment or equivalent te	st results during current v	alidity period in su	ipport of this ap	plication (those to ESCC listed t		
Testing Lev	el LAT		Date code	Quantity	Delivered	
		April 201	7 to March 2019	9 33 456 parts		
tart of qualification	9	Current PID \	/erified bv:	CNES	10	
tart or quamounor.			omou ay.			
		Ref No:	1G2 PID 100 19	9WQ		
*Provide details in b	ox:	Issue:	19	Date	19/12/2019	
19		Rev Date:	18/12/2019		2	
					11	
ng facilities surveyed	by:	CNES on 18/12/2018				
Yes ⊠	E		epresentative) A	Agency	(Date)	
		In taxiii				
	VARIANTS 03, 06 03, 06 03, 06 03, 06 anufacturer proporation sused for ification testing: Issue: 2/3 03 Issue: 7/6 2/3 1/4 1/5 1/5 1/5 1/5 1/5 1/5 1/5	NARIANTS RANGE OF CO O3, 06 Deviations to LVT to used: Issue: 2/3 No □ Yes O3 Issue: 7/6 No ☒ Yes Ment or equivalent test results during current was tart of qualification Provide details in box: 19 O3, 06 No ☒ Yes No ☐ Yes O4 O5 O6 No ☒ Yes O6 No ☒ Yes O7 O7 O7 O7 O7 O7 O7 O7 O7 O	rig series and families) submitted for Extension of Qualification (A) VARIANTS RANGE OF COMPONENTS 03, 06 See box 14 03, 06 O3, 06 03, 06 O3, 06 anufacturer 2 Location of Manufacturing Plant Avenue du Colonel Prat 21850 SAINT APOLLINAIRE – Franco Sused for ification testing: Issue: 2 / 3 No Yes (supply of 15) 03 Issue: 7 / 6 Deviations from current Specifications: 4 See See See See See See See See See S	VARIANTS RANGE OF COMPONENTS BASED ON 03, 06 See box 14 0805 1210	VARIANTS	

Capacitors, Fixed, Chip, Ceramic Dielectric, type I, based on types 0805, 1206, 1210, 1812, 2220

Executive Member: CNES

17/12/2019 Date:

Page 2 Appl. No.

109P rev1

12

13

Failure Analysis, DPA, NCCS available:

Yes

No

 \times (Supply data)

Ref. No's and purposes:

The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein.

Date:

19/12/2019

JP. BUSSENOT

(Signature of the Executive Coordinator)

Continuation of Boxes above:

14

Style	Model	Detail Spec.	Variants (1)	Capacitance Range (pF)	Rated Volt. (V)	Tolerance (±%)	TC (ppm/°C)
0805	A_12C	3009/003	03, 06	4.7 to 9.1 10 to 1 500 1800 to 2200 (2)	50, 100 50	0.5 pF 1, 2, 5, 10 1, 2, 5, 10	± 30
1206	A_20C	3009/022	03, 06	10 to 3 900 4 700 (2)	50, 100 50	1, 2, 5, 10	± 30
1210	A_13C	3009/004	03, 06	22 to 6 800 8 200 to 10 000	50, 100 50	1, 2, 5, 10	± 30
1812	A_14C	3009/005	03, 06	100 to 15 000	50, 100	1, 2, 5, 10	± 30
2220	A_15C	3009/006	03, 06	470 to 33 000	50, 100	1, 2, 5, 10	± 30

⁽¹⁾ Variant 01 (AgPd) replaced in 2013 with variant 03 (AgPdPt) was removed from TPC PID revision 15
(2) Extension of 50V qualified ranges for 0805 and 1206 ranges is covered with the 2012/2013 similar extension of 50V qualified ranges for 1210 sizes. Electrical (same dielectric thickness therefore same electrical field) and Mechanical data (smaller chip sizes) including evaluation testing were presented as part of the introduction of ceramic 90C (report 1G2-220038Y-00CQ dated 26/11/2012)



Component title:

Capacitors, Fixed, Chip, Ceramic Dielectric, type I, based on types 0805, 1206, 1210, 1812, 2220

Appl. No.

Page 3

D) - Comment of		Executive Men	nber: CNES	Date:	17/12/2019	109P rev1
Non compliance	to ESCC requirements:					15
No.:	Specification		Paragraph		Non compliand	e
				8		
Additional tasks	required to achieve full co	ompliance for ESC	CC qualification or rationale for accep	tability of		16
noncompliance:						
Executive Manag	ger Disposition		5. = 5			17
Application Appro	oval: Yes 🗸	No 🗆				
Action / Remarks	10.00					
					201	
Date: 77	01.202			4	5. KM	
Dale.	. Co a	-		B. Sc	chade, Head of ESA Produ	uct Assurance
				and s	Safety Department	

Capacitors, Fixed, Chip, Ceramic Dielectric, type I, based on types 0805, 1206, 1210, 1812, 2220 Component Title:

Executive Member: Date: 17/12/2019

Page 4 Appl. No.

109P rev1

18

ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 3009 generic specification; Chart V (for ESCC/QPL parts); (for ESCC/QML parts) Or PID-TFD

Tests vehicle identification/description:

3009003061301JC - DC 1727	AN20CE0332KT2 - DC 1735
3009022063921FE - DC 1820	AD20CE0272KT3 - DC 1839
3009004061501FE - DC 1751 3009004061002JC - DC 1805 AN13CE0392KT5 - DC 1739	3009005061502JE - DC 1817 3009006063302FE - DC 1730, 1843

Detail Specification reference:

3009/003/004/005/006/022

Chart F4	Test	Tick when done	Conditions	Date Code	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Environmental / Mechanical Subgroup	Mounting	×	IEC 60384-1	1727 1820 1735 (a) 1839 (b) 1751 1805 1817 1730 1843	20 20 20 20 20 20 20 20 20 20	0	(a) 1206 / AN20CE0332J2L (T2) (b) 1206 / AD20CE0272J2L (T3)
	Rapid Change of Temperature	⊠	IEC 60068-2-14	1727 1820 1735 (a) 1839 (b) 1751 1805 1817 1730 1843	20 20 20 20 20 20 20 20 20 20	0	
	Steady State Humidity	×	ESCC 3009, Para. 8.2	1727 1820 1735 (a) 1839 (b) 1751 1805 1817 1730 1843	20 20 20 20 20 20 20 20 20 20	0	1 000 hours

	Visual Inspection	×	ESCC 3009, Para. 8.5	1727 1820 1735 (a) 1839 (b) 1751 1805 1817 1730 1843	20 20 20 20 20 20 20 20 20 20	0	
	Mounting	×	IEC 60384-1	1727 1735 (a) 1751 1739 (c) 1805 1817 1730 1820 1839 (b) 1843	20 40 20 40 40 20 20 20 20 2 x 25	0	(c) 1210 / AN13CE0392J2K (T5)
Endurance Subgroup	Operating Life	×	ESCC 3009, Para. 8.9	1727 1735 (a) 1751 1739 (c) 1805 1817 1730 1820 1839 (b) 1843	20 40 20 40 40 20 20 20 20 20 2 x 25	0	2 000 hours
	Electrical Measurements during Endurance Testing	×	ESCC 3009, Para. 8.9	1727 1735 (a) 1751 1739 (c) 1805 1817 1730 1820 1839 (b) 1843	20 40 20 40 40 20 20 20 20 20 2 x 25	0	
	Mounting		IEC 60384-1				Option
roup ()	Temperature Coefficient (Type I)	×	ESCC 3009, Para. 8.10	1735 (a)	5	0	
Electrical Subgroup (Elect. Meas.)	Temperature Characteristic (Type II)		ESCC 3009, Para. 8.10				Not Applicable
Electri (Ele	Robustness of Terminations	\boxtimes	ESCC 3009, Para 8.7	1735 (a) 1751 1817 1843	20 6 6 6	0	
mbly ibility roup	Solderability	⊠	IEC 60068-2-58 Test Td	1825	6	0	Customer LAT3
Assembly Capability Subgroup	Permanence of Marking		ESCC 24800				Not Applicable

Additional Tests	Insulation resistance at +125°C	⊠	ESCC 3009 lss. 1 Para 9.4.1.3	1727 1730 1751 1817 1820 1843 1845	6 6 6 6 6 6	0	
AC				10.10			
Path -							



Capacitors, Fixed, Chip, Ceramic Dielectric, type I, based on types 0805, 1206, 1210, 1812, 2220

CNES Executive Member:

Component title:

Date: 17/12/2019

Page 6 Appl. No.

109P rev1

NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL

ENTRIES Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 22	Additional Comments.